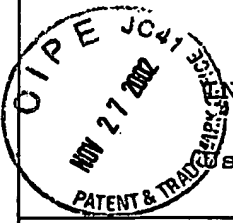


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U.S. Department of Commerce  
Patent and Trademark OfficeAtty. Docket No.  
2271/66770Serial No.  
10/075,481

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Applicant  
Hideyuke YAMAGUCHIFiling Date  
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1734

## U.S. PATENT DOCUMENTS

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	AA						
	AB						
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	AI						
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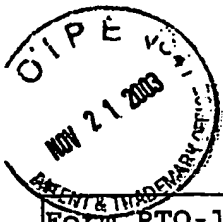
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<del>AL</del>	<del>2 6 1 2 2 6 6</del>	<del>09/29/88</del>	<del>Japan</del>			<del>X</del>	
AM							
AN							
AO							

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Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date if Appropriate
<i>SC</i>	AA	4 9 5 7 8 0 8	09/18/1990	Arai et al.	442	149	
	AB						
	AC						
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	Document Number	Date	Country	Class	Subclass	Translation
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<del>AL</del>	<del>10 1 4 7 0 7 5</del>	<del>06/02/1998</del>	<del>previously cited Japan</del>			<del>ABST.</del>
AM						
AN						
AO						

## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

	AP	
	AQ	
	AR	

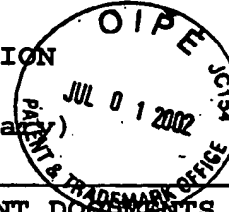
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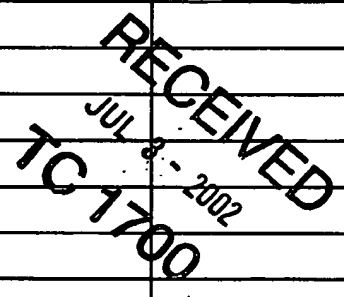
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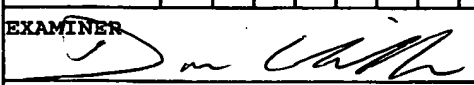
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INFORMATION DISCLOSURE CITATION BY APPLICANT (Use several sheets if necessary)				Applicant Hideyuke YAMAGUCHI			
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U.S. PATENT DOCUMENTS													
Examiner Initial		Document Number							Date	Name	Class	Subclass	Filing Date if Appropriate
DC	AA	5	7	0	7	7	1	2	January 13, 1998	Fujimura et al.	428	195.1	
DC	AB	5	0	9	1	2	5	7	February 25, 1992	Nonogake et al.	428	411.1	
	AC												
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		Yes	No											
DC	AL	3	1	9	3	4	4	5	August 23, 1991	Japan	—	—	ABST.	
DC	AM	6	2	1	9	8	4	59	September 2, 1987	Japan	—	—	ABST.	
DC	AN	3	2	4	0	5	9	6	October 25, 1991	Japan	—	—	ABST.	
	AO	5	4	0	3	3	1	17	March 10, 1979	Japan	—	—	ABST.	

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														Yes	No
DL	AP	9	0	5	2	4	6	9		February 25, 1997	Japan	—	—	ABST.	
DL	AQ	1	1	3	0	9	9	54		November 9, 1999	Japan	—	—	ABST.	
DL	AR	8	3	3	2	7	8	5		December 17, 1996	Japan	—	—	ABST.	
DL	AS	1	0	2	4	6	6	7		January 26, 1989	Japan	—	—	ABST.	
DL	AT	1	1	2	3	5	8	85		August 31, 2002 <del>April 16, 2002</del>	Japan	—	—	ABST.	
DL	AU	1	0	1	4	7	0	75		June 2, 1998	Japan	—	—	ABST.	
DL	AV	1	0	2	3	6	0	11		September 8, 1998	Japan	—	—	ABST.	
	AW	1	0	1	4	7	0	75		June 2, 1998	duplicate entry Japan	—	—	see above ABST.	
DL	AX	1	1	2	3	5	8	55		August 31, 1999	Japan	—	—	ABST.	

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